



JRW
PATENT
8053-1016

IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Kazuhiko NAKAJIMA et al. Conf. 9942

Application No. 10/625,695 Group 2811

Filed July 24, 2003 Examiner Ori Nadav

PRODUCTION PROCESS FOR PRODUCING
SEMICONDUCTOR DEVICES, SEMICONDUCTOR
DEVICES PRODUCED THEREBY, AND TEST
SYSTEM FOR CARRYING OUT YIELD-RATE
TEST IN PRODUCTION OF SUCH
SEMICONDUCTOR DEVICES

AMENDMENT

Assistant Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

March 14, 2006

Sir:

In response to the Official Action mailed December 14, 2005, please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 9 of this paper.